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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded - Microcontrollers</u>"

Details	
Product Status	Obsolete
Core Processor	F ² MC-16FX
Core Size	16-Bit
Speed	32MHz
Connectivity	LINbus, SCI, UART/USART
Peripherals	DMA, LVD, POR, PWM, WDT
Number of I/O	37
Program Memory Size	64KB (64K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	4K x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 5.5V
Data Converters	A/D 16x8/10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	48-LQFP
Supplier Device Package	48-LQFP (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/mb96f612abpmc-gse2



1. Product Lineup

Features			CY96610	Remark		
Product Typ			Flash Memory Product			
Subclock			Subclock can be set by software			
Dual Operat	tion Flash Memory	RAM	-			
32.5KB + 32KB 4KB		CY96F612R, CY96F612A	Product Options			
64.5KB + 32	2KB	10KB	CY96F613R, CY96F613A	R: MCU with CAN		
128.5KB + 3	32KB	10KB	CY96F615R, CY96F615A	A: MCU without CAN		
Package			LQFP-48			
			LQA048			
DMA			2ch			
USART			3ch	LIN-USART 2/7/8		
	with automatic LIN-Heatransmission/reception	ader	Yes (only 1ch)	LIN-USART 2		
	with 16 byte RX- and TX-FIFO		No			
8/10-bit A/D	Converter		16ch	AN 0/1/3/4/6 to 10/ 12/14/16/24/25/30/31		
	with Data Buffer		No			
	with Range Comparato	r	Yes			
	with Scan Disable		No			
	with ADC Pulse Detecti	ion	No			
16-bit Reloa	ad Timer (RLT)		3ch	RLT 1/3/6		
16-bit Free-	Running Timer (FRT)		4ch	FRT 0 to 3 FRT 0 to 3 does not have external clock input pin		
16-hit Innut	Capture Unit (ICU)		7ch	ICU 0/1/4 to 6/9/10		
10 bit input	Captare Offit (100)		(3 channels for LIN-USART)	(ICU 6/9/10 for LIN-USART)		
16 bit Outpu	ut Compare Unit (OCU)		5ch	OCU 0/1/4/6/7		
10-bit Outpu	at Compare Offit (OCO)		0011	(OCU 4 for FRT clear)		
8/16-bit Pro	grammable Pulse Genera	itor (PPG)	8ch (16-bit) / 16ch (8-bit)	PPG 0/1/3/4/6/7/12/14		
	with Timing point captu	re	Yes			
	with Start delay		No			
	with Ramp		No			
Quadrature (QPRC)	Position/Revolution Coun	iter	2ch	QPRC 0/1		
CAN Interfa	се		1ch	CAN 2 32 Message Buffers		
External Inte	errupts (INT)		11ch	INT 0/2/3/4/7 to 13		
Non-Maskal	ble Interrupt (NMI)		1ch			
Real Time C			1ch			
I/O Ports			35 (Dual clock mode) 37 (Single clock mode)			
Clock Calibration Unit (CAL)			1ch			
Clock Output Function			2ch			
	Low Voltage Detection Function		Yes	Low voltage detection function can be disabled by software		
Hardware Watchdog Timer			Yes			
On-chip RC			Yes			
On-chip Deb			Yes			
nte'	55 ·		1			

Note:

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All signals of the peripheral function in each product cannot be allocated by limiting the pins of package. It is necessary to use
the port relocate function of the general I/O port according to your function use.



4. Pin Description

Pin Name	Feature	Description
ADTG_R	ADC	Relocated A/D converter trigger input pin
AlNn	QPRC	Quadrature Position/Revolution Counter Unit n input pin
ANn	ADC	A/D converter channel n input pin
AVcc	Supply	Analog circuits power supply pin
AVRH	ADC	A/D converter high reference voltage input pin
AVss	Supply	Analog circuits power supply pin
BINn	QPRC	Quadrature Position/Revolution Counter Unit n input pin
С	Voltage regulator	Internally regulated power supply stabilization capacitor pin
CKOTn	Clock Output function	Clock Output function n output pin
CKOTn_R	Clock Output function	Relocated Clock Output function n output pin
CKOTXn	Clock Output function	Clock Output function n inverted output pin
DEBUG I/F	OCD	On Chip Debugger input/output pin
INn	ICU	Input Capture Unit n input pin
INTn	External Interrupt	External Interrupt n input pin
INTn_R	External Interrupt	Relocated External Interrupt n input pin
INTn_R1	External Interrupt	Relocated External Interrupt n input pin
MD	Core	Input pin for specifying the operating mode
NMI	External Interrupt	Non-Maskable Interrupt input pin
OUTn	OCU	Output Compare Unit n waveform output pin
OUTn_R	OCU	Relocated Output Compare Unit n waveform output pin
Pnn_m	GPIO	General purpose I/O pin
PPGn	PPG	Programmable Pulse Generator n output pin (16bit/8bit)
PPGn_B	PPG	Programmable Pulse Generator n output pin (16bit/8bit)
RSTX	Core	Reset input pin
RXn	CAN	CAN interface n RX input pin
SCKn	USART	USART n serial clock input/output pin
SCKn_R	USART	Relocated USART n serial clock input/output pin
SINn	USART	USART n serial data input pin
SINn_R	USART	Relocated USART n serial data input pin
SOTn	USART	USART n serial data output pin
SOTn_R	USART	Relocated USART n serial data output pin
TINn	Reload Timer	Reload Timer n event input pin
TOTn	Reload Timer	Reload Timer n output pin
TTGn	PPG	Programmable Pulse Generator n trigger input pin
TXn	CAN	CAN interface n TX output pin
V _{cc}	Supply	Power supply pin
V _{ss}	Supply	Power supply pin
X0	Clock	Oscillator input pin
X0A	Clock	Subclock Oscillator input pin
X1	Clock	Oscillator output pin
X1A	Clock	Subclock Oscillator output pin

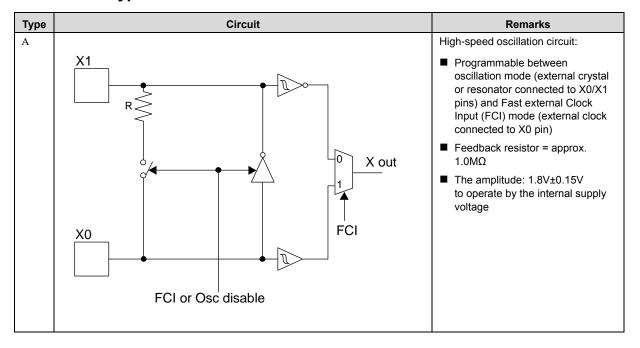


Pin Name	Pin Name Feature Description					
ZINn	QPRC	Quadrature Position/Revolution Counter Unit n input pin				

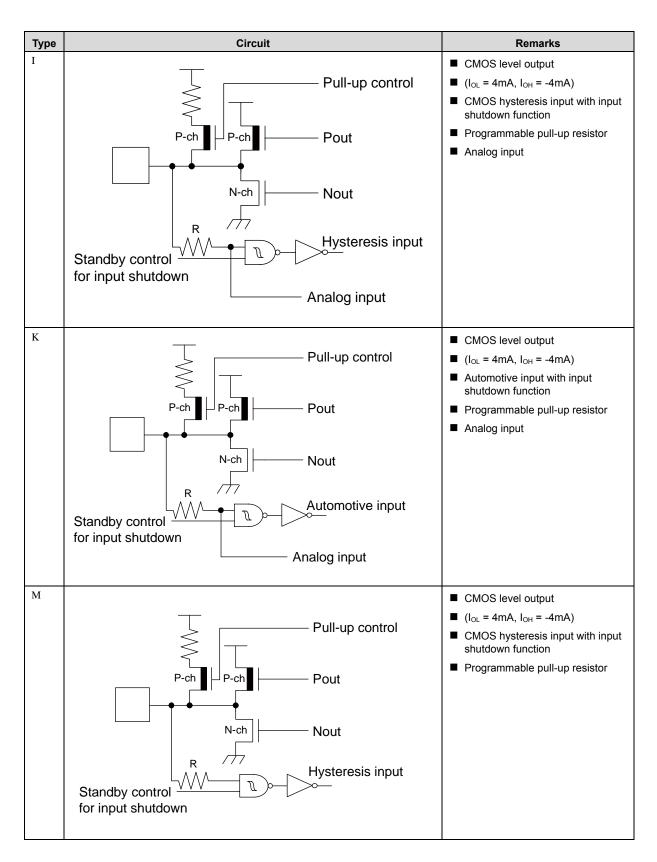
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6. I/O Circuit Type









7. Memory Map

USER ROM*1
Reserved
Boot-ROM
Peripheral
Reserved
ROM/RAM
MIRROR
Internal RAM bank0
Reserved
Peripheral
GPR*3
DMA
Reserved
Peripheral

^{*1:} For details about USER ROM area, see "

User ROM Memory Map for Flash Devices" on the following pages.

GPR: General-Purpose Register

The DMA area is only available if the device contains the corresponding resource.

The available RAM and ROM area depends on the device.

^{*2:} For RAMSTART addresses, see the table on the next page.

^{*3:} Unused GPR banks can be used as RAM area.



10. Serial Programming Communication Interface

USART pins for Flash serial programming (MD = 0, DEBUG I/F = 0, Serial Communication mode)

CY96610							
Pin Number USART Number Normal Function							
7		SIN2					
8	USART2	SOT2					
9		SCK2					
20		SIN7_R					
19	USART7	SOT7_R					
18		SCK7_R					
22		SIN8_R					
21	USART8	SOT8_R					
23		SCK8_R					



11. Interrupt Vector Table

Vector Number	Offset in Vector Table	Vector Name	Cleared by DMA	Index in ICR to Program	Description
0	3FC _H	CALLV0	No	-	CALLV instruction
1	3F8 _H	CALLV1	No	-	CALLV instruction
2	3F4 _H	CALLV2	No	-	CALLV instruction
3	3F0 _H	CALLV3	No	-	CALLV instruction
4	3EC _H	CALLV4	No	-	CALLV instruction
5	3E8 _H	CALLV5	No	-	CALLV instruction
6	3E4 _H	CALLV6	No	-	CALLV instruction
7	3E0 _H	CALLV7	No	-	CALLV instruction
8	3DC _H	RESET	No	-	Reset vector
9	3D8 _H	INT9	No	-	INT9 instruction
10	3D4 _H	EXCEPTION	No	-	Undefined instruction execution
11	3D0 _H	NMI	No	-	Non-Maskable Interrupt
12	3CC _H	DLY	No	12	Delayed Interrupt
13	3C8 _H	RC_TIMER	No	13	RC Clock Timer
14	3C4 _H	MC_TIMER	No	14	Main Clock Timer
15	3C0 _H	SC_TIMER	No	15	Sub Clock Timer
16	3BC _H	LVDI	No	16	Low Voltage Detector
17	3B8 _H	EXTINT0	Yes	17	External Interrupt 0
18	3B4 _H	-	-	18	Reserved
19	3B0 _H	EXTINT2	Yes	19	External Interrupt 2
20	ЗАС _н	EXTINT3	Yes	20	External Interrupt 3
21	3A8 _H	EXTINT4	Yes	21	External Interrupt 4
22	3A4 _H	-	-	22	Reserved
23	3A0 _H	-	-	23	Reserved
24	39C _H	EXTINT7	Yes	24	External Interrupt 7
25	398 _H	EXTINT8	Yes	25	External Interrupt 8
26	394 _H	EXTINT9	Yes	26	External Interrupt 9
27	390 _H	EXTINT10	Yes	27	External Interrupt 10
28	38C _H	EXTINT11	Yes	28	External Interrupt 11
29	388 _H	EXTINT12	Yes	29	External Interrupt 12
30	384 _H	EXTINT13	Yes	30	External Interrupt 13
31	380 _H	-	-	31	Reserved
32	37C _H	-	-	32	Reserved
33	378 _H	-	-	33	Reserved
34	374 _H	-	-	34	Reserved
35	370 _H	CAN2	No	35	CAN Controller 2
36	36C _H	-	-	36	Reserved
37	368 _H	-	-	37	Reserved
38	364 _H	PPG0	Yes	38	Programmable Pulse Generator 0
39	360 _H	PPG1	Yes	39	Programmable Pulse Generator 1



Vector Number	Offset in Vector Table	Vector Name	Cleared by DMA	Index in ICR to Program	Description
40	35C _H	-	-	40	Reserved
41	358 _H	PPG3	Yes	41	Programmable Pulse Generator 3
42	354 _H	PPG4	Yes	42	Programmable Pulse Generator 4
43	350 _H	-	-	43	Reserved
44	34C _H	PPG6	Yes	44	Programmable Pulse Generator 6
45	348 _H	PPG7	Yes	45	Programmable Pulse Generator 7
46	344 _H	-	-	46	Reserved
47	340 _H	-	-	47	Reserved
48	33C _H	-	-	48	Reserved
49	338 _H	-	-	49	Reserved
50	334 _H	PPG12	Yes	50	Programmable Pulse Generator 12
51	330 _H	-	-	51	Reserved
52	32C _H	PPG14	Yes	52	Programmable Pulse Generator 14
53	328 _H	-	-	53	Reserved
54	324 _H	-	-	54	Reserved
55	320 _H	-	-	55	Reserved
56	31C _H	-	-	56	Reserved
57	318 _H	-	-	57	Reserved
58	314 _H	-	-	58	Reserved
59	310 _H	RLT1	Yes	59	Reload Timer 1
60	30C _H	-	-	60	Reserved
61	308 _H	RLT3	Yes	61	Reload Timer 3
62	304 _H	-	-	62	Reserved
63	300 _H	-	-	63	Reserved
64	2FC _H	RLT6	Yes	64	Reload Timer 6
65	2F8 _H	ICU0	Yes	65	Input Capture Unit 0
66	2F4 _H	ICU1	Yes	66	Input Capture Unit 1
67	2F0 _H	-	-	67	Reserved
68	2EC _H	-	-	68	Reserved
69	2E8 _H	ICU4	Yes	69	Input Capture Unit 4
70	2E4 _H	ICU5	Yes	70	Input Capture Unit 5
71	2E0 _H	ICU6	Yes	71	Input Capture Unit 6
72	2DC _H	-	-	72	Reserved
73	2D8 _H	-	-	73	Reserved
74	2D4 _H	ICU9	Yes	74	Input Capture Unit 9
75	2D0 _H	ICU10	Yes	75	Input Capture Unit 10
76	2CC _H	-	-	76	Reserved
77	2C8 _H	OCU0	Yes	77	Output Compare Unit 0
78	2C4 _H	OCU1	Yes	78	Output Compare Unit 1
79	2C0 _H	-	-	79	Reserved
80	2BC _H	-	-	80	Reserved



CAUTION:

The occurrence of latch-up not only causes loss of reliability in the semiconductor device, but can cause injury or damage from high heat, smoke or flame. To prevent this from happening, do the following:

- 1. Be sure that voltages applied to pins do not exceed the absolute maximum ratings. This should include attention to abnormal noise, surge levels, etc.
- Be sure that abnormal current flows do not occur during the power-on sequence.
- Observance of Safety Regulations and Standards

Most countries in the world have established standards and regulations regarding safety, protection from electromagnetic interference, etc. Customers are requested to observe applicable regulations and standards in the design of products.

■ Fail-Safe Design

Any semiconductor devices have inherently a certain rate of failure. You must protect against injury, damage or loss from such failures by incorporating safety design measures into your facility and equipment such as redundancy, fire protection, and prevention of over-current levels and other abnormal operating conditions.

■ Precautions Related to Usage of Devices

Cypress semiconductor devices are intended for use in standard applications (computers, office automation and other office equipment, industrial, communications, and measurement equipment, personal or household devices, etc.).

CAUTION:

Customers considering the use of our products in special applications where failure or abnormal operation may directly affect human lives or cause physical injury or property damage, or where extremely high levels of reliability are demanded (such as aerospace systems, atomic energy controls, sea floor repeaters, vehicle operating controls, medical devices for life support, etc.) are requested to consult with sales representatives before such use. The company will not be responsible for damages arising from such use without prior approval.

12.2 Precautions for Package Mounting

Package mounting may be either lead insertion type or surface mount type. In either case, for heat resistance during soldering, you should only mount under Cypress's recommended conditions. For detailed information about mount conditions, contact your sales representative.

■ Lead Insertion Type

Mounting of lead insertion type packages onto printed circuit boards may be done by two methods: direct soldering on the board, or mounting by using a socket.

Direct mounting onto boards normally involves processes for inserting leads into through-holes on the board and using the flow soldering (wave soldering) method of applying liquid solder. In this case, the soldering process usually causes leads to be subjected to thermal stress in excess of the absolute ratings for storage temperature. Mounting processes should conform to Cypress recommended mounting conditions.

If socket mounting is used, differences in surface treatment of the socket contacts and IC lead surfaces can lead to contact deterioration after long periods. For this reason it is recommended that the surface treatment of socket contacts and IC leads be verified before mounting.

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13.7 Turn on Sequence of Power Supply to A/D Converter and Analog Inputs

It is required to turn the A/D converter power supply (AV_{CC}, AVRH) and analog inputs (ANn) on after turning the digital power supply (V_{CC}) on.

It is also required to turn the digital power off after turning the A/D converter supply and analog inputs off. In this case, AVRH must not exceed AV_{CC} Input voltage for ports shared with analog input ports also must not exceed AV_{CC} (turning the analog and digital power supplies simultaneously on or off is acceptable)

13.8 Pin Handling when Not Using the A/D Converter

If the A/D converter is not used, the power supply pins for A/D converter should be connected such as $AV_{CC} = V_{CC} AV_{SS} = AVRH = V_{SS}$.

13.9 Notes on Power-on

To prevent malfunction of the internal voltage regulator, supply voltage profile while turning the power supply on should be slower than $50\mu s$ from 0.2V to 2.7V.

13.10Stabilization of Power Supply Voltage

If the power supply voltage varies acutely even within the operation safety range of the V_{CC} power supply voltage, a malfunction may occur. The V_{CC} power supply voltage must therefore be stabilized. As stabilization guidelines, the power supply voltage must be stabilized in such a way that V_{CC} ripple fluctuations (peak to peak value) in the commercial frequencies (50Hz to 60Hz) fall within 10% of the standard V_{CC} power supply voltage and the transient fluctuation rate becomes $0.1V/\mu s$ or less in instantaneous fluctuation for power supply switching.

13.11 Serial Communication

There is a possibility to receive wrong data due to noise or other causes on the serial communication.

Therefore, design a printed circuit board so as to avoid noise.

Consider receiving of wrong data when designing the system. For example apply a checksum and retransmit the data if an error occurs.

13.12Mode Pin (MD)

Connect the mode pin directly to Vcc or Vss pin. To prevent the device unintentionally entering test mode due to noise, lay out the printed circuit board so as to minimize the distance from the mode pin to Vcc or Vss pin and provide a low-impedance connection.



14. Electrical Characteristics

14.1 Absolute Maximum Ratings

		0 1111	R	ating			
Parameter	Symbol	Condition	Min	Max	Unit	Remarks	
Power supply voltage ^[1]	V _{CC}	-	V _{SS} - 0.3	V _{SS} + 6.0	V		
Analog power supply voltage ^[1]	AV _{CC}	-	V _{SS} - 0.3	V _{SS} + 6.0	V	$V_{CC} = AV_{CC}^{[2]}$	
Analog reference voltage ^[1]	AVRH	-	V _{SS} - 0.3	V _{SS} + 6.0	V	AV _{CC} ≥ AVRH, AVRH ≥ AV _{SS}	
Input voltage[1]	Vi	-	V _{SS} - 0.3	V _{SS} + 6.0	V	$V_1 \le V_{CC} + 0.3V^{[3]}$	
Output voltage ^[1]	Vo	-	V _{SS} - 0.3	V _{SS} + 6.0	V	$V_0 \le V_{CC} + 0.3V^{[3]}$	
Maximum Clamp Current	I _{CLAMP}	-	-4.0	+4.0	mA	Applicable to general purpose I/O pins [4]	
Total Maximum Clamp Current	Σ I _{CLAMP}	-	-	13	mA	Applicable to general purpose I/O pins [4]	
"L" level maximum output current	I _{OL}	-	-	15	mA		
"L" level average output current	I _{OLAV}	-	-	4	mA		
"L" level maximum overall output current	ΣI _{OL}	-	-	32	mA		
"L" level average overall output current	ΣI _{OLAV}	-	-	16	mA		
"H" level maximum output current	I _{OH}	-	-	-15	mA		
"H" level average output current	I _{OHAV}	-	-	-4	mA		
"H" level maximum overall output current	Σι _{οн}	-	-	-32	mA		
"H" level average overall output current	ΣI _{OHAV}	-	-	-16	mA		
Power consumption ^[5]	P _D	T _A = +125°C	-	284 ^[6]	mW		
Operating ambient temperature	T _A	-	-40	+125 ^[7]	°C		
Storage temperature	T _{STG}	-	-55	+150	°C		

^{[1]:} This parameter is based on $V_{SS} = AV_{SS} = 0V$.

[2]: AV_{CC} and V_{CC} must be set to the same voltage. It is required that AV_{CC} does not exceed V_{CC} and that the voltage at the analog inputs does not exceed AV_{CC} when the power is switched on.

[3]: V_I and V_O should not exceed V_{CC} + 0.3V. V_I should also not exceed the specified ratings. However if the maximum current to/from an input is limited by some means with external components, the I_{CLAMP} rating supersedes the V_I rating. Input/Output voltages of standard ports depend on V_{CC} .

[4]:

- Applicable to all general purpose I/O pins (Pnn_m).
- Use within recommended operating conditions.
- Use at DC voltage (current).
- The +B signal should always be applied a limiting resistance placed between the +B signal and the microcontroller.
- The value of the limiting resistance should be set so that when the +B signal is applied the input current to microcontroller pin does not exceed rated values, either instantaneously or for prolonged periods.

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14.3 DC Characteristics

14.3.1 Current Rating

 $(V_{CC} = AV_{CC} = 2.7V \text{ to } 5.5V, V_{SS} = AV_{SS} = 0V, T_A = -40^{\circ}C \text{ to } + 125^{\circ}C)$

cc = AVcc = 2.7V	Symbol Pin Conditions Value					11	_	
Parameter	Name Conditions	Conditions	Min	Тур	Max	Unit	Remarks	
			PLL Run mode with CLKS1/2 =	-	25	1	mA	T _A = +25°C
	I _{CCPLL}		CLKB = CLKP1/2 = 32MHz Flash 0 wait (CLKRC and CLKSC stopped)	-	-	34	mA	T _A = +105°C
			(CERRC and CERSC Stopped)	-	-	35	mA	T _A = +125°C
			Main Run mode with CLKS1/2 = CLKB = CLKP1/2 = 4MHz	-	3.5	-	mA	T _A = +25°C
	I _{CCMAIN}		Flash 0 wait (CLKPLL, CLKSC and CLKRC	-	-	7.5	mA	T _A = +105°C
			stopped)	-	-	8.5	mA	T _A = +125°C
	I _{CCRCH} Vcc		RC Run mode with CLKS1/2 = CLKB = CLKP1/2 = CLKRC = 2MHz Flash 0 wait (CLKMC, CLKPLL and CLKSC stopped)	-	1.7	-	mA	T _A = +25°C
Power supply current in Run modes ^[1]		Vcc		-	-	5.5	mA	T _A = +105°C
				-	-	6.5	mA	T _A = +125°C
			RC Run mode with CLKS1/2 = CLKB = CLKP1/2 = CLKRC =	-	0.15	-	mA	T _A = +25°C
	I _{CCRCL}		100kHz Flash 0 wait (CLKMC, CLKPLL and CLKSC	-	-	3.2	mA	T _A = +105°C
			stopped)	-	-	4.2	mA	T _A = +125°C
			Sub Run mode with CLKS1/2 = CLKB = CLKP1/2 = 32kHz Flash 0 wait (CLKMC, CLKPLL and CLKRC	-	0.1	-	mA	T _A = +25°C
	I _{CCSUB}			-	-	3	mA	T _A = +105°C
			stopped)	-	-	4	mA	T _A = +125°C



		Pin			Value			
Parameter	Symbol	Nam e	Conditions	Min	Тур	Max	Unit	Remarks
			DI I. Class made with	-	6.5	-	mA	T _A = +25°C
	I _{CCSPLL}		PLL Sleep mode with CLKS1/2 = CLKP1/2 = 32MHz	-	-	13	mA	T _A = +105°C
			(CLKRC and CLKSC stopped)	-	-	14	mA	T _A = +125°C
			Main Sleep mode with	-	0.9	-	mA	T _A = +25°C
	I _{CCSMAIN}		CLKS1/2 = CLKP1/2 = 4MHz, SMCR:LPMSS = 0	-	-	4	mA	T _A = +105°C
			(CLKPLL, CLKRC and CLKSC stopped)	-	-	5	mA	T _A = +125°C
	I _{ссsясн}	Vcc	RC Sleep mode with CLKS1/2 = CLKP1/2 = CLKRC = 2MHz, SMCR:LPMSS = 0 (CLKMC, CLKPLL and CLKSC stopped)	-	0.5	-	mA	T _A = +25°C
Power supply current in Sleep modes ^[1]				-	1	3.5	mA	T _A = +105°C
				-	1	4.5	mA	T _A = +125°C
			RC Sleep mode with CLKS1/2 = CLKP1/2 = CLKRC = 100kHz (CLKMC, CLKPLL and CLKSC	-	0.06	-	mA	T _A = +25°C
	I _{CCSRCL}			-	-	2.7	mA	T _A = +105°C
			stopped)	-	-	3.7	mA	T _A = +125°C
			Sub Sleep mode with	-	0.04	-	mA	T _A = +25°C
	I _{CCSSUB}		CLKS1/2 = CLKP1/2 = 32kHz, (CLKMC, CLKPLL and CLKRC stopped)	-	-	2.5	mA	T _A = +105°C
				-	-	3.5	mA	T _A = +125°C



14.3.2 Pin Characteristics

 $(V_{CC} = AV_{CC} = 2.7V \text{ to } 5.5V, V_{SS} = AV_{SS} = 0V, T_A = -40^{\circ}\text{C to } + 125^{\circ}\text{C})$

			0V, I _A = - 40°C to +	Value				_
Parameter	Symbol	Pin Name	Conditions	Min Typ Max		Unit	Remarks	
		5	-	V _{cc} ×0.7	-	V _{CC} + 0.3	V	CMOS Hysteresis input
	V _{IH}	Port inputs Pnn_m	-	V _{CC} ×0.8	-	V _{CC} + 0.3	٧	AUTOMOTIVE Hysteresis input
"H" level input	V _{IHX0S}	X0	External clock in "Fast Clock Input mode"	VD×0.8	-	VD	V	VD=1.8V±0.15V
voltage	V _{IHX0AS}	X0A	External clock in "Oscillation mode"	V _{CC} ×0.8	-	V _{CC} + 0.3	V	
	V_{IHR}	RSTX	-	V _{CC} ×0.8	-	V _{CC} + 0.3	V	CMOS Hysteresis input
	V_{IHM}	MD	-	V _{CC} - 0.3	-	V _{cc} + 0.3	V	CMOS Hysteresis input
	V _{IHD}	DEBUG I/F	-	2.0	-	V _{CC} + 0.3	V	TTL Input
			-	V _{SS} - 0.3	_	V _{cc} ×0.3	V	CMOS Hysteresis input
	V _{IL}	Port inputs Pnn_m	-	V _{SS} - 0.3	-	V _{CC} ×0.5	V	AUTOMOTIVE Hysteresis input
"L" level input	V _{ILX0S}	Х0	External clock in "Fast Clock Input mode"	V _{SS}	-	VD×0.2	V	VD=1.8V±0.15V
voltage	V _{ILX0AS}	X0A	External clock in "Oscillation mode"	V _{SS} - 0.3	-	V _{CC} ×0.2	V	
	V_{ILR}	RSTX	-	V _{SS} - 0.3	-	V _{CC} ×0.2	V	CMOS Hysteresis input
	V _{ILM}	MD	-	V _{SS} - 0.3	-	V _{SS} + 0.3	V	CMOS Hysteresis input
	V_{ILD}	DEBUG I/F	-	V _{SS} - 0.3	-	0.8	V	TTL Input
"H" level output voltage	V _{OH4}	4mA type	$I_{OH} = -4mA$ $I_{OH} = -4mA$ $I_{OH} = -1.5mA$	V _{cc} - 0.5	-	Vcc	V	
"L" level	V _{OL4}	4mA type	$4.5V \le V_{CC} \le 5.5V$ $I_{OL} = +4mA$ $2.7V \le V_{CC} < 4.5V$ $I_{OL} = +1.7mA$		-	0.4	V	
	V _{OLD}	DEBUG I/F	$V_{CC} = 2.7V$ $I_{OL} = +25mA$	0	-	0.25	V	
Input leak current	I _{IL}	Pnn_m	$V_{SS} < V_I < V_{CC}$ $AV_{SS} < V_I < AV_{CC}$, AVRH	- 1	-	+ 1	μA	
Pull-up resistance value	R _{PU}	Pnn_m	V _{CC} = 5.0V ±10%	25	50	100	kΩ	_
Input capacitance	C _{IN}	Other than C, Vcc, Vss, AVcc, AVss, AVRH	-	-	5	15	pF	



14.4.3 Built-in RC Oscillation Characteristics

($V_{CC} = AV_{CC} = 2.7V$ to 5.5V, $V_{SS} = AV_{SS} = 0V$, $T_A = -40$ °C to + 125°C)

		Value					
Parameter	Symbol	Min	Тур	Max	Unit	Remarks	
Clock frequency	f _{RC}	50	100	200	kHz	When using slow frequency of RC oscillator	
		1	2	4	MHz	When using fast frequency of RC oscillator	
RC clock stabilization time	trcstab	80	160	320	μs	When using slow frequency of RC oscillator (16 RC clock cycles)	
		64	128	256	μ\$	When using fast frequency of RC oscillator (256 RC clock cycles)	

14.4.4 Internal Clock Timing

 $(V_{CC} = AV_{CC} = 2.7V \text{ to } 5.5V, V_{SS} = AV_{SS} = 0V, T_A = -40^{\circ}C \text{ to } + 125^{\circ}C)$

Parameter	Comple of	Value		1114	
Parameter	Symbol	Min	Max	Unit	
Internal System clock frequency (CLKS1 and CLKS2)	f _{CLKS1} , f _{CLKS2}	-	54	MHz	
Internal CPU clock frequency (CLKB), Internal peripheral clock frequency (CLKP1)	f _{CLKB} , f _{CLKP1}	-	32	MHz	
Internal peripheral clock frequency (CLKP2)	f _{CLKP2}	-	32	MHz	

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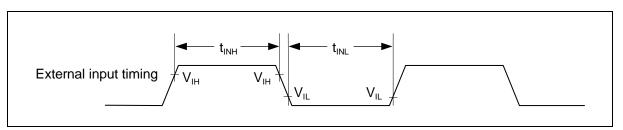


14.4.9 External Input Timing

 $(V_{CC} = AV_{CC} = 2.7V \text{ to } 5.5V, V_{SS} = AV_{SS} = 0V, T_A = -40^{\circ}C \text{ to } + 125^{\circ}C)$

0000							
Down to the state of the state		B: N	Value				
Parameter	Symbol	Pin Name	Min	Max	Unit	Remarks	
		Pnn_m		-	ns	General Purpose I/O	
		ADTG_R				A/D Converter trigger input	
		TINn	2t _{CLKP1} +200			Reload Timer	
	t _{INH} , t _{INL}	TTGn				PPG trigger input	
Input pulse			INn	$(t_{CLKP1}=1/f_{CLKP1})^*$			Input Capture
width		AINn, BINn, ZINn			Quadrature Position/Revolutior Counter		
		INTn, INTn_R, INTn_R1	200	-	ns	External Interrupt	
		NMI				Non-Maskable Interrupt	

^{*:} tclkP1 indicates the peripheral clock1 (CLKP1) cycle time except stop when in stop mode.





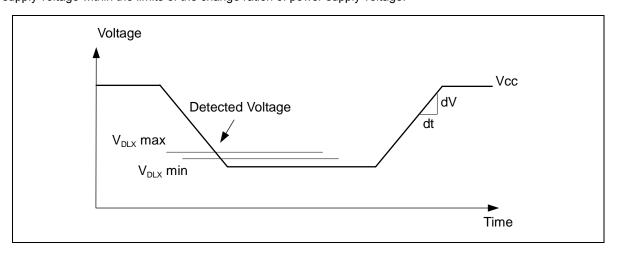
14.6 Low Voltage Detection Function Characteristics

 $(V_{CC} = AV_{CC} = 2.7V \text{ to } 5.5V, V_{SS} = AV_{SS} = 0V, T_A = -40^{\circ}C \text{ to } + 125^{\circ}C)$

D						
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
	V_{DL0}	CILCR:LVL = 0000 _B	2.70	2.90	3.10	V
	V _{DL1}	CILCR:LVL = 0001 _B	2.79	3.00	3.21	V
	V _{DL2}	CILCR:LVL = 0010 _B	2.98	3.20	3.42	V
Detected voltage ^[1]	V _{DL3}	CILCR:LVL = 0011 _B	3.26	3.50	3.74	V
	V_{DL4}	CILCR:LVL = 0100 _B	3.45	3.70	3.95	V
	V _{DL5}	CILCR:LVL = 0111 _B	3.73	4.00	4.27	V
	V _{DL6}	CILCR:LVL = 1001 _B	3.91	4.20	4.49	V
Power supply voltage change rate ^[2]	dV/dt	-	- 0.004	-	+ 0.004	V/µs
Therefore Council 10.	V _{HYS}	CILCR:LVHYS=0	-	-	50	mV
Hysteresis width		CILCR:LVHYS=1	80	100	120	mV
Stabilization time	T _{LVDSTAB}	-	-	-	75	μs
Detection delay time	t _d	-	-	-	30	μs

^{[1]:} If the power supply voltage fluctuates within the time less than the detection delay time (td), there is a possibility that the low voltage detection will occur or stop after the power supply voltage passes the detection range.

[2]: In order to perform the low voltage detection at the detection voltage (V_{DLX}), be sure to suppress fluctuation of the power supply voltage within the limits of the change ration of power supply voltage.

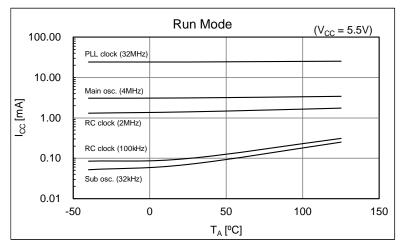


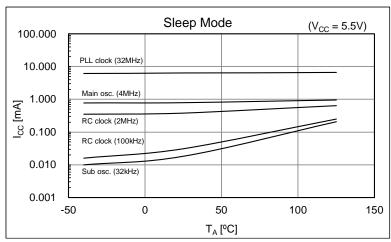
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15. Example Characteristics

This characteristic is an actual value of the arbitrary sample. It is not the guaranteed value. CY96F615





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Document History

Document Title: CY96610 Series, F²MC, 16FX, 16-bit Proprietary Microcontroller

Document Number: 002-04709

Revision	ECN	Orig. of Change	Submission Date	Description of Change
**	_	KSUN	01/31/2014	Migrated to Cypress and assigned document number 002-04709. No change to document contents or format.
*A	5146534	KSUN	02/29/2016	Updated to Cypress template
*B	5735123	KUME	05/15/2017	Updated the Ordering Information and the Package Dimension For details, please see 18. Major Changes.
*C	5809040	MIYH	07/11/2017	Updated the Ordering Information For details, please see 18. Major Changes.
*D	5978072	MIYH	11/30/2017	Revised the following items: Marketing Part Numbers changed from an MB prefix to a CY prefix. 16. Ordering Information For details, please see 18. Major Changes.